

Application/Control No.	Applicant(s)/Pate Reexamination	pplicant(s)/Patent under examination	
10/574,816	YUGE ET AL.		
Examiner	Art Unit		
Taeyoon Kim	1651		

	SEARCHED		
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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